# **Power MOSFET**

# 40 V, 5.8 A, Dual N-Channel SOIC-8

#### **Features**

- Designed for use in low voltage, high speed switching applications
- Ultra Low On-Resistance Provides
   Higher Efficiency and Extends Battery Life
  - $-R_{DS(on)} = 0.027 \Omega$ ,  $V_{GS} = 10 V$  (Typ)
  - $-R_{DS(on)} = 0.034 \Omega$ ,  $V_{GS} = 4.5 V$  (Typ)
- Miniature SOIC-8 Surface Mount Package Saves Board Space
- Diode is Characterized for Use in Bridge Circuits
- Diode Exhibits High Speed, with Soft Recovery
- Pb-Free Package is Available

## **Applications**

- DC-DC Converters
- Computers
- Printers
- Cellular and Cordless Phones
- Disk Drives and Tape Drives

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	$V_{DSS}$	40	V
Gate-to-Source Voltage - Continuous	V <sub>GS</sub>	±20	V
	I <sub>D</sub> I <sub>DM</sub>	5.8 29	Adc Apk
Drain Current (Note 2) - Continuous @ T <sub>A</sub> = 25°C	I <sub>D</sub> 4.6		Adc
Total Power Dissipation @ T <sub>A</sub> = 25°C (Note 1) @ T <sub>A</sub> = 25°C (Note 2)	P <sub>D</sub> 2.0 1.29		W
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	ô
Single Pulse Drain-to-Source Avalanche Energy - Starting $T_J = 25^{\circ}C$ ( $V_{DD} = 40$ Vdc, $V_{GS} = 5.0$ Vdc, Vdc, Peak $I_L = 7.0$ Apk, $L = 10$ mH, $R_G = 25$ $\Omega$ )	E <sub>AS</sub>	245	mJ
Thermal Resistance - Junction-to-Ambient (Note 1) - Junction-to-Ambient (Note 2)	$R_{ hetaJA}$	62.5 97	°C/W
Maximum Lead Temperature for Soldering Purposes for 10 Sec	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- When surface mounted to an FR4 board using 1" pad size, t ≤ 10 s
- 2. When surface mounted to an FR4 board using 1" pad size, t = steady state

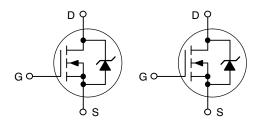


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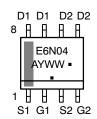
V <sub>DSS</sub>	R <sub>DS(ON)</sub> Typ	I <sub>D</sub> Max	
40 V	27 m $\Omega$ @ V <sub>GS</sub> = 10 V	5.8 A	

#### **N-Channel**



# MARKING DIAGRAM & PIN ASSIGNMENT





E6N04 = Specific Device Code A = Assembly Location

Y = Year WW = Work Week • Pb-Free Package

(Note: Microdot may be in either location)

### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMD6N04R2G	SOIC-8 (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

# **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

Chara	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage $(V_{GS}=0\ Vdc,\ I_D=250\ \mu A)$ Temperature Coefficient (Positive)			40 -	47 45	-	Vdc mV/°C
Zero Gate Voltage Drain Current (V <sub>DS</sub> = 40 Vdc, V <sub>GS</sub> = 0 Vdc, T <sub>J</sub> = 25°C) (V <sub>DS</sub> = 40 Vdc, V <sub>GS</sub> = 0 Vdc, T <sub>J</sub> = 125°C)			- -	- -	1.0 10	μAdc
Gate-Body Leakage Current (V <sub>GS</sub> = ±20 Vdc, V <sub>DS</sub> = 0 Vdc)			-	-	± 100	nAdc
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage (V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μAdc) Temperature Coefficient (Negative)			1.0	1.9 4.7	3.0	Vdc mV/°C
Static Drain-to-Source On-State Resistance ( $V_{GS} = 10 \text{ Vdc}$ , $I_D = 5.8 \text{ Adc}$ ) ( $V_{GS} = 4.5 \text{ Vdc}$ , $I_D = 3.9 \text{ Adc}$ )			- -	0.027 0.034	0.034 0.043	Ω
Forward Transconductance (V <sub>DS</sub> = 10 Vdc, I <sub>D</sub> = 5.8 Adc)			-	8.12	-	Mhos
DYNAMIC CHARACTERISTICS						
Input Capacitance		C <sub>iss</sub>	-	723	900	pF
Output Capacitance	(V <sub>DS</sub> = 32 Vdc, V <sub>GS</sub> = 0 Vdc, f = 1.0 MHz)	C <sub>oss</sub>	-	156	225	
Reverse Transfer Capacitance		C <sub>rss</sub>	-	53	75	
SWITCHING CHARACTERISTICS (N	otes 3 & 4)			•	•	•
Turn-On Delay Time		t <sub>d(on)</sub>	-	10	18	ns
Rise Time	$(V_{DD} = 20 \text{ Vdc}, I_D = 5.8 \text{ A},$	t <sub>r</sub>	-	20	35	
Turn-Off Delay Time	$V_{GS} = 10 \text{ V},$ $R_G = 6 \Omega)$	t <sub>d(off)</sub>	-	45	70	
Fall Time		t <sub>f</sub>	-	40	65	1
Turn-On Delay Time		t <sub>d(on)</sub>	-	15	-	ns
Rise Time	$(V_{DD} = 20 \text{ Vdc}, I_D = 5.8 \text{ A},$	t <sub>r</sub>	-	55	-	1
Turn-Off Delay Time	$V_{GS} = 4.5 \text{ V},$ $R_G = 6 \Omega)$	t <sub>d(off)</sub>	-	30	-	1
Fall Time		t <sub>f</sub>	-	35	-	1
Gate Charge	(V <sub>DS</sub> = 20 Vdc, V <sub>GS</sub> = 10 Vdc,	$Q_{T}$	-	20	30	nC
		Q <sub>gs</sub>	-	2.5	_	
	I <sub>D</sub> = 5.8 A)	Q <sub>gd</sub>	-	5.5	_	
BODY-DRAIN DIODE RATINGS (Not	e 3)					
Diode Forward On-Voltage	$(I_S = 1.7 \text{ Adc}, V_{GS} = 0 \text{ V})$ $(I_S = 1.7 \text{ Adc}, V_{GS} = 0 \text{ V}, T_J = 150^{\circ}\text{C})$	V <sub>SD</sub>	-	0.76 0.56	1.1	Vdc
Reverse Recovery Time		t <sub>rr</sub>	-	23	_	ns
	$(I_S = 1.7 \text{ A}, V_{GS} = 0 \text{ V}, \\ dI_S/dt = 100 \text{ A/}\mu\text{s})$	t <sub>a</sub>	-	16	-	
		t <sub>b</sub>	-	7	-	
Reverse Recovery Stored Charge ( $I_S = 1.7 \text{ A}$ , $dI_S/dt = 100 \text{ A/}\mu\text{s}$ , $V_{GS} = 1.00 \text{ A/}\mu\text{s}$	Q <sub>RR</sub>	-	20	-	nC	

<sup>3.</sup> Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%. 4. Switching characteristics are independent of operating junction temperature.

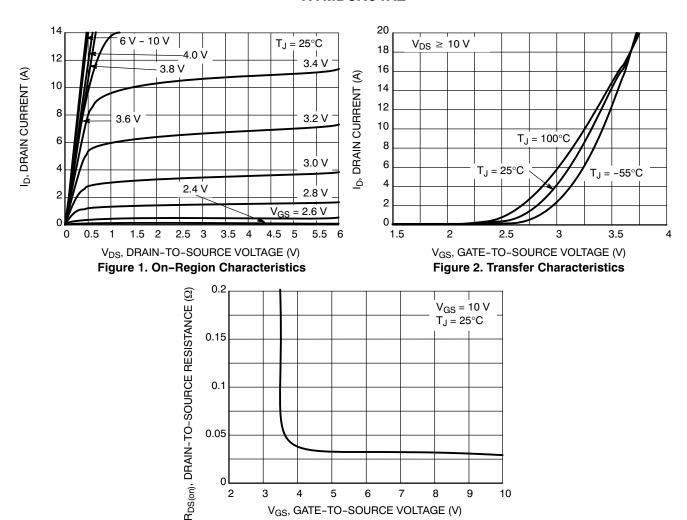


Figure 3. On-Resistance vs. Gate-to-Source Voltage

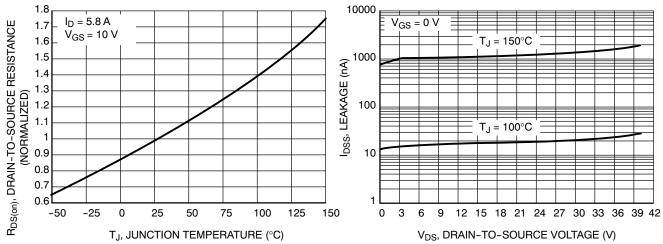


Figure 4. On Resistance Variation with Temperature

Figure 5. Drain-to-Source Leakage Current vs. Voltage

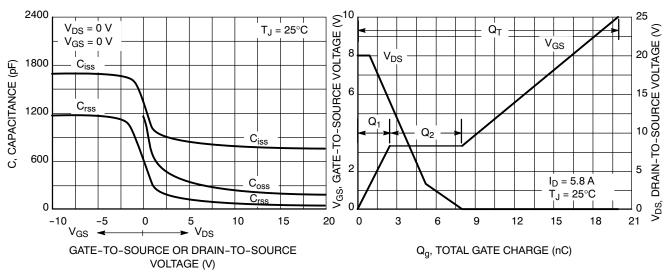
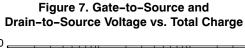


Figure 6. Capacitance Variation



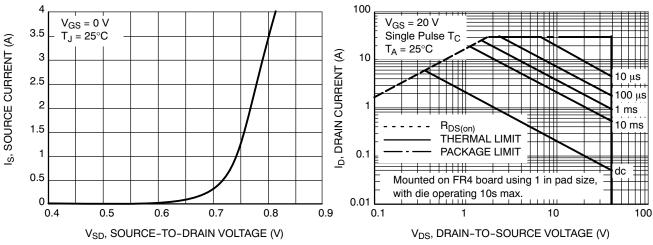
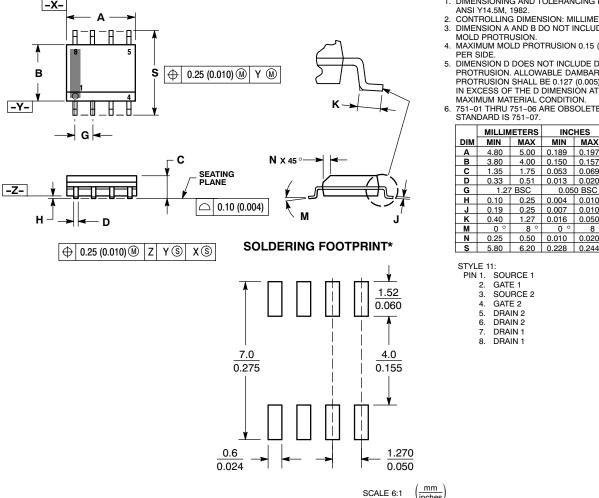


Figure 8. Diode Forward Voltage vs. Current

Figure 9. Maximum Rated Forward Biased Safe Operating Area

#### PACKAGE DIMENSIONS

#### SOIC-8 NB CASE 751-07 **ISSUE AJ**



NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006)
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT
- MAXIMUM MATERIAL CONDITION. 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

	MILLIN	IETERS	INCHES			
DIM	MIN	MAX	MIN	MAX		
Α	4.80	5.00	0.189	0.197		
В	3.80	4.00	0.150	0.157		
С	1.35	1.75 0.053		0.069		
D	0.33	0.51	0.013	0.020		
G	1.27	1.27 BSC		0.050 BSC		
н	<b>H</b> 0.10		0.004	0.010		
J	0.19	0.25	0.007	0.010		
K	0.40	1.27	0.016	0.050		
М	0 °	8 °	0 °	8 °		
N	0.25	0.50	0.010	0.020		
9	5.80	6.20	0.228	0.244		

DRAIN 1

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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